

4 <sup>th</sup> Semester	REC4D001	Semiconductor Devices	L-T-P 3-0-0	3 CREDITS
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**MODULE-I (08 Hours)**

**Introduction to the quantum theory of solids:** Formation of energy bands; the k-space diagram (two and three dimensional representation), conductors, semiconductors and insulators.

**Electrons and Holes in semiconductors:** Silicon crystal structure; Donors and acceptors in the band model; electron effective mass; Density of states; Thermal equilibrium; and Fermi-Dirac distribution function for electrons and holes; Fermi energy. Equilibrium distribution of electrons & holes: derivation of  $n$  and  $p$  from  $D(E)$  and  $f(E)$ , Fermi level and carrier concentrations.

**MODULE-I (09 Hours)**

The  $np$  product and the intrinsic carrier concentration. General theory of  $n$  and  $p$ ; Carrier concentrations at extremely high and low temperatures: complete ionization, partial ionization and freeze-out; Energy-band diagram and Fermi-level, Variation of  $E_F$  with doping concentration and temperature.

**Motion and Recombination of Electrons and Holes:** Carrier drift: Electron and hole mobilities; Mechanism of carrier scattering; Drift current and conductivity.

**MODULE-III (10 Hours)**

**Motion and Recombination of Electrons and Holes (continued):** Carrier diffusion: diffusion current, Total current density; relation between the energy diagram and potential, electric field; Einstein relationship between diffusion coefficient and mobility; Electron-hole recombination; Thermal generation.

**PN Junction:** Building blocks of the pn junction theory: Energy band diagram and depletion layer of a pn junction, Built-in potential; Depletion layer model: Field and potential in the depletion layer, depletion-layer width; Reverse-biased PN junction; Capacitance-voltage characteristics; Junction breakdown: peak electric field. Tunneling breakdown and avalanche breakdown; Carrier injection under forward bias-Quasi-equilibrium boundary condition; current continuity equation; Excess carriers in forward-biased pn junction; PN diode I-V characteristic, Charge storage.

**MODULE-IV (08 Hours)**

**The Bipolar Transistor:** Introduction, Modes of operation; Minority Carrier distribution, Collector current, Base current, current gain, Base width Modulation by collector current, Breakdown mechanism, Equivalent Circuit Models – Ebers -Moll Model.

**MODULE-V (10 Hours)**

**Metal-Semiconductor Junction:** Schottky Diodes: Built-in potential, Energy-band diagram, I-V characteristics, Comparison of the Schottky barrier diode and the pn-junction diode; Ohmic contacts: tunneling barrier, specific contact resistance.

**MOS Capacitor:** The MOS structure, Energy band diagrams, Flat-band condition and flat-band voltage, Surface accumulation, surface depletion, Threshold condition and threshold voltage, MOS C-V characteristics,  $Q_{inv}$  in MOSFET.

**Books:**

- Semiconductor Physics and Devices-Donald A. Neamen, Tata McGraw Hill Publishing Company Limited, New Delhi, 3<sup>rd</sup> Edition.
- Solid State Electronics Devices-Ben. G. Streetman and Sanjay Banarjee, Pearson Education, New Delhi, 6<sup>th</sup> Edition.
- Modern Semiconductor Devices for Integrated Circuits-Chenming Calvin Hu, Pearson Education/Prentice Hall, 2009.
- Physics of Semiconductor Devices-S.M. Sze and Kwok K. Ng, Wiley India Pvt. Limited, New Delhi, 3<sup>rd</sup> Edition.
- Physics of Semiconductor Devices-Dillip K. Roy, University Press (India) Pvt. Ltd., Hyderabad, 2<sup>nd</sup> Edition
- Semiconductor Physics and Devices- Fowler, Oxford University Press.
- Solid State Electronics Devices-D.K. Bhattacharya and Rajnish Sharma, Oxford University Press, New Delhi, 2<sup>nd</sup> Edition
- Fundamentals of Semiconductor Devices-M.K. Achuthan and K.N. Bhatt, Tata McGraw Hill Publishing Company Limited, New Delhi.